


<b>Search Notes</b>  	<b>Application/Control No.</b>  10655094	<b>Applicant(s)/Patent Under Reexamination</b>  QIU ET AL.
	<b>Examiner</b>  /BINH K TIEU/	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
379	1.01	03/02/2008	BKT
379	1.03-1.04	03/02/2008	BKT
379	9	03/02/2008	BKT
379	10.01	03/02/2008	BKT
379	15.01	03/02/2008	BKT
379	22.02	03/02/2008	BKT
379	23	03/02/2008	BKT
379	27.01	03/02/2008	BKT
379	27.03	03/02/2008	BKT
379	27.08	03/02/2008	BKT
379	29.01	03/02/2008	BKT
379	32.04	03/02/2008	BKT
375	243, 245, 260, 316	03/02/2008	BKT
341	155-156	03/02/2008	BKT
341	158	03/02/2008	BKT

SEARCH NOTES		
Search Notes	Date	Examiner
WEST DATABASES SEARCHES	03/02/2008	BKT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
379	1.03-1.04	03/02/2008	BKT
379	22.02	03/02/2008	BKT
375	316	03/02/2008	BKT
375	243	03/02/2008	BKT
375	245	03/02/2008	BKT
375	260	03/02/2008	BKT